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Indian Standard

QUARTZ CRYSTAL UNITS USED FOR FREQUENCY CONTROL AND SELECTION — SPECIFICATION

PART 5 SERIES CX FOR OSCILLATORS
Section 10 Quartz Crystal Unit Type CX-10

भारतीय मानक

आवृति नियंत्रण और चयन में प्रयुक्त क्वार्टज किस्टल इकाइयाँ — विशिष्टि भाग 5 दोलकों के लिये सी एक्स श्रेणी अनुभाग 10 क्वार्टज किस्टल इकाई टाईप सी एक्स-10

UDC 621:373:5

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BUREAU OF INDIAN STANDARDS MANAK BHAVAN, 9 BAHADUR SHAH ZAFAR MARG NEW DELHI 110002

FOREWORD

This Indian Standard (Part 5'Sec 10) was adopted by the Bureau of Indian Standards on 17 March 1989, after the draft finalized by the Piezoelectric Devices for Frequency Control and Selection Sectional Committee had been approved by the Electronics and Telecommunication Division Council.

This standard shall be read in conjunction with IS 8271 (Part 1): 1981 'Specification for quartz crystal units used for frequency control and selection: Part 1 General requirements and tests (first revision)'.

This standard is based on JSS 50909 (1971) 'Detail specification for crystal unit, quartz, styles QC-29, QC-30, QC-31, QC-32, QC-33, QC-34 and QC-35', issued by the Directorate of Standardization, Ministry of Defence, India. The type of quartz crystal unit covered in this standard is equivalent to style QC-33 of JSS 50909 (1971).

For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, abserved or calculated, expressing the result of a test or analysis, shall be rounded off in accordance with IS 2:1960 'Rules for rounding off numerical values (revised)'. The number of significant places retained in the rounded off value should be the same as that of the specified value in this standard.

Indian Standard

QUARTZ CRYSTAL UNITS USED FOR FREQUENCY CONTROL AND SELECTION — SPECIFICATION

PART 5 SERIES CX FOR OSCILLATORS Section 10 Quartz Crystal Unit Type CX-10

1 SCOPE

1.1 This standard (Part 5/Sec 10) specifies detail requirements for the characteristics of quartz crystal unit Type CX-10 used for frequency control and selection in oscillators.

2 REFERENCES

2.1 The following Indian Standards have been referred to in this standard:

IS No.

Title

IS 4570 (Part 6): 1984 Specification for crystal unit holders: Part 6 Metal, solder seal, twopin, crystal unit holder, Type CX

IS 8271 (Part 1): 1981 Specification for quartz crystal units used for frequency control and selection: Part 1 General requirements and tests (first revision)

3 OUTLINE AND DIMENSIONS

3.1 Holder outline shall conform to Type CX [see IS 4570 (Part 6): 1984].

4 MARKING

4.1 See 8 of IS 8271 (Part 1): 1981.

5 CONSTRUCTION AND WORKMANSHIP

5.1 See 7 of IS 8271 (Part 1): 1981.

6 TEST SCHEDULE AND DETAIL REQUIREMENTS

6.1 General Conditions for Test

See 9.2 of IS 8271 (Part 1): 1981.

6.2 Test Schedule

The sequence and grouping of type, routine and acceptance tests shall be in accordance with 9.1 of IS 8271 (Part 1): 1981.

6.3 Detail Requirements

The detail requirements applicable to this particular type of crystal unit shall be as specified in Table 1.

Table 1 Detail Requirements of Quartz Crystal Unit Type CX-10

Characteristic a) Type of holder b) Frequency range c) Frequency tolerance: 1) Operating temperature range 2) Room temperature d) Frequency stability e) Load capacitance f) Mode of oscillation g) Reference temperature h) Temperature range: 1) Operating 2) Operable j) Test set, calibration values and rated drive level k) Capacitance shunt m) Resonance resistance n) Shock [As in 9.15 (severity A) of 1S 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted p) Vibration [As in 9.16.1 (Severity A) of IS 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted 5 ppm	(Clause 6.3)				
b) Frequency range c) Frequency tolerance: 1) Operating temperature range 2) Room temperature 480 ppm 45 ppm 1nfinity f) Mode of oscillation Third mechanical overtone g) Reference temperature h) Temperature range: 1) Operating 2) Operable j) Test set, calibration values and rated drive level k) Capacitance shunt m) Resonance resistance n) Shock [As in 9.15 (severity A) of 1S 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted p) Vibration [As in 9.16.1 (Severity A) of 1S 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted 2) Resonance resistance change permitted 4) Ageing: 17 to 61 MHz ±20 ppm ±5 ppm Infinity Third mechanical overtone 85 ± 1°C -55 to 80°C -55 to 80°C 7 pF, Max 40 ohms, Max ±5 ppm ±10 percent ±5 ppm ±10 percent	Characteristic	Requirement			
c) Frequency tolerance: 1) Operating temperature range 2) Room temperature 480 ppm 4) Frequency stability 45 ppm Infinity f) Mode of oscillation g) Reference temperature h) Temperature range: 1) Operating 2) Operable j) Test set, calibration values and rated drive level k) Capacitance shunt m) Resonance resistance n) Shock [As in 9.15 (severity A) of 1S 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted p) Vibration [As in 9.16.1 (Severity A) of 1S 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted 2) Resonance resistance change permitted 4 See Table 2 7 pF, Max 40 ohms, Max 40 ohms, Max 410 percent 45 ppm 410 percent 45 ppm 410 percent 45 ppm 410 percent 45 ppm 410 percent	a) Type of holder	CX (see 1)			
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d) Frequency stability e) Load capacitance f) Mode of oscillation g) Reference temperature h) Temperature range: 1) Operating 2) Operable j) Test set, calibration values and rated drive level k) Capacitance shunt m) Resonance resistance n) Shock [As in 9.15 (severity A) of IS 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted p) Vibration [As in 9.16.1 (Severity A) of IS 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted 2) Resonance resistance change permitted 2) Resonance resistance change permitted 4.5 ppm 4.10 percent 4.5 ppm 4.10 percent 4.5 ppm 4.10 percent		±20 ppm			
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n) Shock [As in 9.15 (severity A) of 1S 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted p) Vibration [As in 9.16.1 (Severity A) of IS 8271 (Part 1): 1981]: 1) Frequency change permitted 2) Resonance resistance change permitted 4) Ageing: ±5 ppm ±5 ppm ±10 percent	k) Capacitance shunt	7 pF, Max			
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2) Resonance resistance change permitted ±10 percent q) Ageing:	(Severity A) of IS 8271				
permitted ±10 percent q) Ageing:	1) Frequency change permitted	±5 ppm			
		±10 percent			
Frequency change permitted 5 ppm	q) Ageing:				
	Frequency change permitted	5 ppm			

Table 2 Test Set, Calibration Values and Rated Drive Level

[Table 1 (i)]

Frequency Range	Calibration Values		Rated Drive	Test Set
	Resistance	Resistor Voltage Drop	Level	ડ ા
MHz	ohms	volt	mW	
(1)	(2)	(3)	(4)	(5)
17 to 25	40	0.28	2·0 ± 0·1	TS-683/ TSM
>25 up to 0	51 40	0.20	1·0 ± 0 2	1314

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